## Search Notes



Application/Control No.

10816789

Reexamination ABANAMI ET AL.

Applicant(s)/Patent Under

Examiner

Ahn, Sangwoo

Art Unit 2166

## **SEARCHED**

Class	Subclass	Date	Examiner
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## **SEARCH NOTES**

Search Notes	Date	Examiner
EAST updated (see search history printout(s))	1/3/2007	SW

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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